<u>MOSFET</u> – Power, Single, N-Channel 40 V, 1.1 mΩ, 258 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- LFPAK4 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	e		V _{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	I _D	258	А
Current R _{θJC} (Notes 1, 3)	State	T _C = 100°C		182	
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	134	W
R _{0JC} (Note 1)		$T_C = 100^{\circ}C$		67	
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	I _D	44	А
Current R _{θJA} (Notes 1, 2, 3)	Sidle	T _A = 100°C		31	
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.9	W
R _{θJA} (Notes 1, 2)		$T_A = 100^{\circ}C$		1.9	
Pulsed Drain Current	$T_A = 25^{\circ}C$, $t_p = 10 \ \mu s$		I _{DM}	900	А
Operating Junction and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			۱ _S	112	А
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 21 A)			E _{AS}	1359	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.12	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

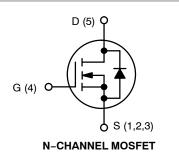
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	1.1 mΩ @ 10 V	258 A
40 V	1.7 mΩ @ 4.5 V	230 A





ORDERING INFORMATION

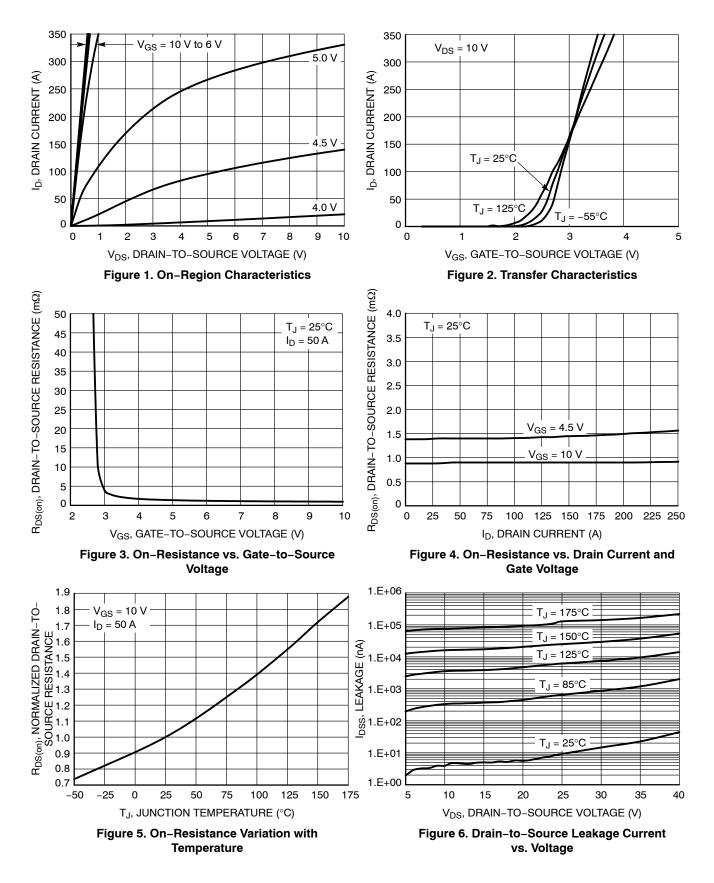
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

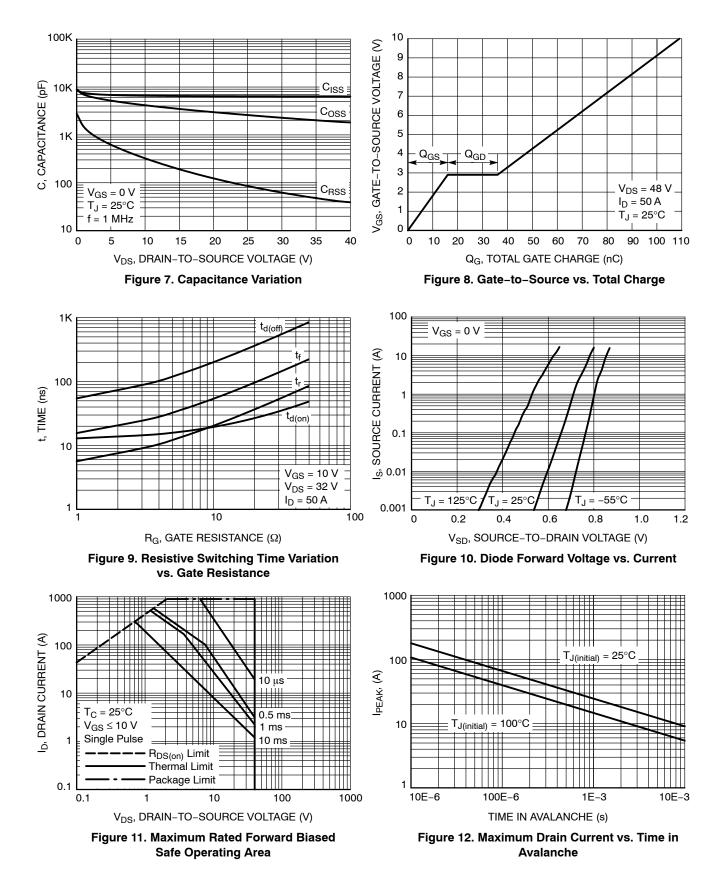
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				-	-		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D	= 250 μA	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				20		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V_{c}$	$T_J = 25^{\circ}C$			10	μΑ
		V _{GS} = 0 V, V _{DS} = 40 V	T _J = 125°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 180 \ \mu A$		1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 50 A		1.4	1.7	mΩ
		V _{GS} = 10 V	I _D = 50 A		0.9	1.2	1
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I	_D = 50 A		285		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}				6330		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MI	Hz, V _{DS} = 20 V		3000		1
Reverse Transfer Capacitance	C _{RSS}				118		1
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 20 V; I_{D} = 50 A			52		nC
Total Gate Charge	Q _{G(TOT)}				109		nC
Threshold Gate Charge	Q _{G(TH)}				9.0		1
Gate-to-Source Charge	Q _{GS}	V _{GS} = 10 V, V _{DS} =	20 V; I _D = 50 A		16		1
Gate-to-Drain Charge	Q _{GD}				20		1
Plateau Voltage	V _{GP}				2.9		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn–On Delay Time	t _{d(ON)}				14		ns
Rise Time	t _r	V _{GS} = 10 V. V			8.1		1
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D} = 50 \rm A, R_{\rm C}$	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 50 A, R_{G} = 2.5 Ω		79		1
Fall Time	t _f				22		1
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.80	1.2	V
		$I_{\rm S} = 50 \text{A}$ $T_{\rm J} = 125^{\circ}\text{C}$			0.65		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/µs, I _S = 50 A			70		ns
Charge Time	t _a				42		1
Discharge Time	t _b				28		1
Reverse Recovery Charge	Q _{RR}				107	l	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

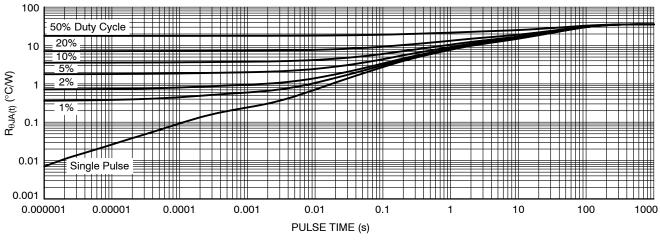
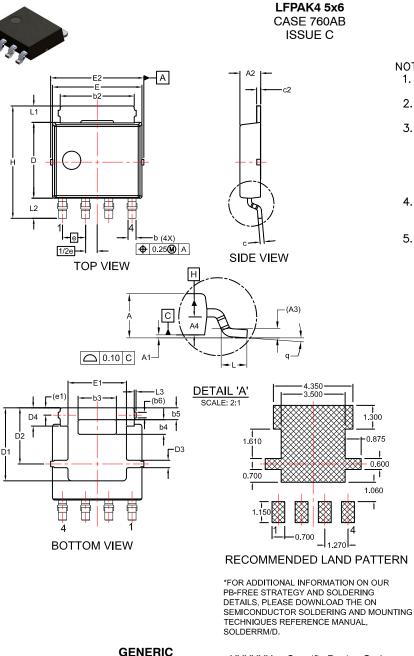


Figure 13. Thermal Characteristics

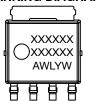
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMYS1D2N04CLTWG	1D2N04CL	LFPAK4 (Pb–Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



MARKING DIAGRAM*



XXXXXX = Specific Device Code А

- = Assembly Location = Wafer Lot WL
 - = Year

Υ

W

= Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

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DESCRIPTION:	LFPAK4 5x6		PAGE 1 OF 1

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DATE 19 NOV 2019

NOTES:

- DIMENSIONING AND TOLERANCING 1. PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: 2.
- MILLIMETERS. DIMENSIONS D AND E DO NOT 3. INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- DIMENSIONS D AND E ARE 4. DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE 5.
 - DETERMINED AT DATUM PLANE H.

UNIT IN MILLIMETER					
DIM	DIM MIN NOM MAX				
A	1.10	1.20	1.30		
A1	0.00	0.08	0.15		
A2	1.10	1.15	1.20		
A3	().25 REF	-		
A4	0.45	0.50	0.55		
b	0.40	0.45	0.50		
b2	3.80	4.10	4.40		
b3	2.00	2.10	2.20		
b4	0.70	0.80	0.90		
b5	0.55	0.65	0.75		
b6		0.31 REI	F		
С	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
D	4.05	4.15	4.25		
D1	3.80	4.00	4.20		
D2	3.00	3.10	3.20		
D3	0.30	0.40	0.50		
D4	0.90	1.00	1.10		
Е	4.80	4.90	5.00		
E1	3.10	3.20	3.30		
E2	5.00	5.15	5.30		
е	1.27 BSC				
1/2e	0.635 BSC				
e1	0.40 REF				
н	6.00	6.15	6.30		
L	0.40	0.65	0.85		
L1	0.80	0.90	1.00		
L2	0.90	1.10	1.30		
L3	0.00	0.10	0.20		
q	0°	4°	8°		

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